

<b>Notice of References Cited</b>	Application/Control No. 10/799,133	Applicant(s)/Patent Under Reexamination ITO, KAZUNARI	
	Examiner Henok G. Heyi	Art Unit 2609	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,197,056 A	03-1993	Van Heusden et al.	369/30.86
*	B	US-5,293,362 A	03-1994	Sakurai et al.	369/30.8
*	C	US-5,422,869 A	06-1995	Versleegers, Jozef C. M.	369/30.97
*	D	US-5,742,571 A	04-1998	Hoshino et al.	369/30.98
*	E	US-5,771,213 A	06-1998	Koshino et al.	369/30.91
*	F	US-5,802,021 A	09-1998	Mukaida, Kumio	369/30.32
*	G	US-5,848,033 A	12-1998	Park, Chan-Sou	369/30.29
*	H	US-5,862,107 A	01-1999	Goto, Souju	386/126
*	I	US-2002/0075767 A1	06-2002	Seo, Seong Hwan	369/30.91
*	J	US-6,618,332 B2	09-2003	Ochi, Hiroshi	369/30.79
*	K	US-2003/0193848 A1	10-2003	Lee, Howard Hong-Dough	369/30.33
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.